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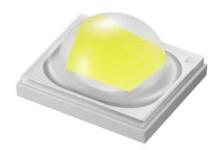






Product Family Data Sheet

LH351B - 3535 Ceramic LED @85℃





Introduction

Features

• Package : Ceramic Substrate LED Package

View Angle: 120 °

Precondition: JEDEC Level 2a
Dimension: 3.5 x 3.5 x 1.93 mm

ESD withstand Voltage : up to ±5KV [HBM]
 Reliability Test : IES-LM-80-08 qualified

Applications

• INDOOR LIGHTING : Spot light, Down light

• OUTDOOR LIGHTING: Street light, Security light, Tunnel light, Parking lots light

• INDUSTRIAL LIGHTING: High-bay light, Low-bay light

CONSUMER LIGHTING: Torch light

SAMSUNG ELECTRONICS

95, Samsung2-Ro, Giheung-Gu, Yongin-City, Gyeonggi-Do 446-711, KOREA



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1. Luminous Flux Characteristics (T_j= 85℃)

Nominal Minimur		Sorting condition Flux ²⁾ @350mA		Calculated Minimum Flux ³⁾		Product Code	BIN Structur	
CCT	CRI ¹⁾	Rank	Min Flux ²⁾	@700mA	@1000mA	@1500mA		е
							SPHWH1L3D30ED4W0F3	Whole
		F3 (G3)	90 (100)	162 (177)	213 (233)	283 (309)	SPHWH1L3D30ED4WPF3	Quarter
2700K	80	()	(= = /	,	(/	(===)	SPHWH1L3D30ED4WMF3	МЗ
2700K	00						SPHWH1L3D30ED4W0G3	Whole
		G3 (H3)	100 (110)	180 (197)	237 (259)	314 (343)	SPHWH1L3D30ED4WPG3	Quarter
		(112)	(112)	(121)	(===)	(5.5)	SPHWH1L3D30ED4WMG3	МЗ
							SPHWH1L3D30ED4V0G3	Whole
3000K	80	80 G3 100 (H3) (110)	180 (197)	237 (259)	314 (343)	SPHWH1L3D30ED4VPG3	Quarter	
		(1.2)	(112)	(121)	(===)	(5.5)	SPHWH1L3D30ED4VMG3	МЗ
							SPHWH1L3D30ED4U0G3	Whole
3500K	80	G3 (H3)	100 (110)	180 (197)	237 (259)	314 (343)	SPHWH1L3D30ED4UPG3	Quarter
		(112)	(112)	(121)		(5.5)	SPHWH1L3D30ED4UMG3	МЗ
							SPHWH1L3D30CD4T0J3	Whole
		J3 (K3)	120 (130)	216 (234)	(308)	377 (408)	SPHWH1L3D30CD4TPJ3	Quarter
	70	(- /	(= = /	(- /	(===)	(= = /	SPHWH1L3D30CD4TMJ3	МЗ
	70						SPHWH1L3D30CD4T0K3	Whole
4000K	4000K	K3 (M3)	130 (140)	234 (253)	308 (333)	408 (441)	SPHWH1L3D30CD4TPK3	Quarter
		()	(112)	(===)	(555)	(***)	SPHWH1L3D30CD4TMK3	МЗ
						SPHWH1L3D30ED4T0G3	Whole	
	80	G3 (H3)	100 (110)	180 (197)	237 (259)	314 (343)	SPHWH1L3D30ED4TPG3	Quarter
		(0)	(1.0)	(-3-)	(=30)	(= .0)	SPHWH1L3D30ED4TMG3	М3

^{()* :} Minimum luminous flux @ 25° C

Notes:

- 1) SAMSUNG ELECTRONICS maintains a tolerance of ±3.0 on CRI measurements.
- 2) SAMSUNG ELECTRONICS maintains a tolerance of ±7% on flux measurements.
- 3) Calculated flux values are for reference only.



1. Luminous Flux Characteristics (T_j= 85℃)

Nominal Minimum CCT CRI¹)		condition @350mA	Calculated Minimum Flux ³⁾			Product Code	BIN Structur
		Min Flux ²⁾	@700mA	@1000mA	@1500mA		е
	J3	120	216	284	377	CDLIMILIAL 2D20CD4DT I2	half
70	(K3)	(130)	(234)	(308)	(408)	3PHWHIL3D30CD4K133	пап
70	K3	130	234	308	408	CDUWU11 2D20CD4DTV2	half
Κ	(M3)	(140)	(253)	(333)	(441)	SERWHILSDSUCD4NINS	Hall
	J3	120	216	284	377	CDUMU11 2D20DD4DT 12	half
	(K3)	(130)	(234)	(308)	(408)	3PHWHIL3D30DD4R1J3	пап
75	K3	130	234	308	408	CDLIWILIAL 2D20DD4DTI/2	half
	(M3)	(140)	(253)	(333)	(441)	3FIIWIIIL3D30DD4H1K3	Hall
	J3	120	216	284	377		half
70	(K3)	(130)	(234)	(308)	(408)	3FHWH1L3D30CD4Q133	Hall
70	K3	130	234	308	408	CDUMU11 2D20CD4OTK2	half
	(M3)	(140)	(253)	(333)	(441)	SPHWHILSD30CD4QTK3	Hall
	J3	120	216	284	377	CDUMU11 2D20DD4OT 12	half
75	(K3)	(130)	(234)	(308)	(408)	3PHWHIL3D30DD4Q133	nan
75	K3	130	234	308	408	CDLIWILIAL 2D20DD4OTI/2	half
	(M3)	(140)	(253)	(333)	(441)	3FFWFIL3D3UDD4QTK3	half
70	J3	120	216	284	377	ODUNALIST ODOOOD 4DT 10	l If
70	(K3)	(130)	(234)	(308)	(408)	SPHWHIL3D30CD4PIJ3	half
	-	Minimum CRI ¹¹ Flux ² Rank 70	Minimum CRI¹¹ Flux²¹ @350mA 70 Rank Min Flux²¹ 70 (K3) (130) K3 130 (M3) (140) (140) 75 (K3) (130) K3 130 (M3) (140) (K3) (130) 70 (K3) (130) 75 (K3) (130) 75 (K3) (130) 75 (K3) (130) 75 (K3) (130) 70 J3 120 (K3) (140) 70 J3 120 (K3) (130) (K3) (130) (140)	Minimum CRI ¹⁾ Rank Min Flux ²⁾ @700mA Rank Min Flux ²⁾ @700mA 70 J3	Minimum CRI¹¹¹ Flux²² @350mA Calculated Minimum Calculated Minimum CRI¹¹¹ 70 Rank Min Flux²² @700mA @1000mA 70 J3 120 216 284 (308) (K3) (130) (234) (308) (308) 75 J3 120 216 284 (308) (K3) (130) (234) (308) (333) 70 K3 130 234 308 (M3) (140) (253) (333) 75 J3 120 216 284 (K3) (130) (253) (333) 75 K3 130 234 308 (M3) (140) (253) (333) 75 K3 130 234 308 (M3) (140) (253) (308) 75 K3 130 234 308 (M3) (140) (253) (333) 70 J3 120 216 284 (K3) (130) (234) (308) 70 J3 120 216 284 (K3) (130) (253) (333)	Minimum CRI¹¹¹ Flux²² @350mA Calculated Minimum Flux³¹¹ 70 Rank Min Flux²² @700mA (21000mA) @1000mA (2000mA) 70 (K3) (130) (234) (308) (408) K3 130 (234) (308) (441) (408) 75 (K3) (130) (253) (333) (441) 75 (K3) (130) (234) (308) (408) K3 130 (234) (308) (441) 70 (K3) (130) (234) (308) (408) K3 130 (234) (308) (408) (K3) (130) (234) (308) (408) (K3) (130) (253) (333) (441) 75 (K3) (130) (253) (333) (441) 76 (K3) (130) (234) (308) (408) (K3) (130) (234) (308) (408) (K3) (130) (253) (333) (441) 76 (K3) (130) (253) (333) (441) 70 (K3) (130) (253) (333) (333) (441) 70 (K3) (130) (253) (333) (333) (441) 70 (K3) (130) (253) (333) (333) (441) 70 (K3) (130) (253) (334) (308) (408) (K3) (130) (234) (308) (408)	Flux Flux Gaster Flux Flu

^{()* :} Minimum luminous flux @ 25℃

Notes:

- 1) SAMSUNG ELECTRONICS maintains a tolerance of ±3.0 on CRI measurements.
- 2) SAMSUNG ELECTRONICS maintains a tolerance of ±7% on flux measurements.
- 3) Calculated flux values are for reference only.



2. Characteristics

1) Electro-optical Characteristics

Item	Unit	Min	Тур	Max
Forward voltage ¹⁾ (@350 mA, Tj = 85° C)	V	2.60	2.85	3.00
Forward voltage¹) (@700 mA, Tj = 85°C)	V		3.02	
Forward voltage¹) (@1000 mA, Tj = 85℃)	V		3.13	
Forward voltage¹) (@1500 mA, Tj = 85℃)	V		3.29	
Operation forward current (Tj = 85℃)	mA	-	-	1500
Thermal resistance, junction to solder point	°C/W	-	4	6
LED junction temperature Tj	°C	_	-	150
Operating temperature range T _{opr}	°C	-40	-	85
Storage temperature range T _{stg}	°C	-40	-	120
Viewing Angle	0	_	120	-

Item	Unit	3000K	5000K
Forward voltage ¹⁾ (@350 mA, Tj = 25°C)	V	2.95	
Forward voltage¹) (@350 mA, Tj = 85°C)	٧	2.85	
Luminous flux ²⁾ (@350 mA, Tj = 25° C)	lm	118	144
Luminous flux²) (@350 mA, Tj = 85℃)	lm	108 133	
Luminous flux ²⁾ (@700 mA, Tj = 85° C)	lm	194	239
Luminous flux² (@1000 mA, Tj = 85℃)	lm	256	315
Luminous flux² (@1500 mA, Tj = 85℃)	lm	339	418

Notes:

- 1) SAMSUNG ELECTRONICS maintains a tolerance of ±0.1V on forward voltage measurements.
- 2) Characteristics @ 25°C are for reference only.

2) Vf Rank

Parameter	Symbol	Condition	Rank	Min.	Тур.	Max.
Forward Voltage	V _F	I _F = 350mA	D4	2.60	-	3.00

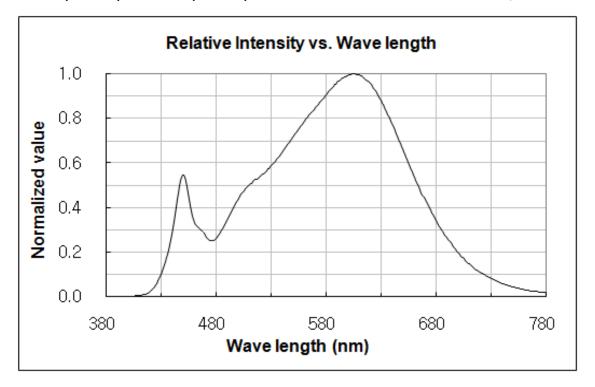


3. Typical Characteristics Graph

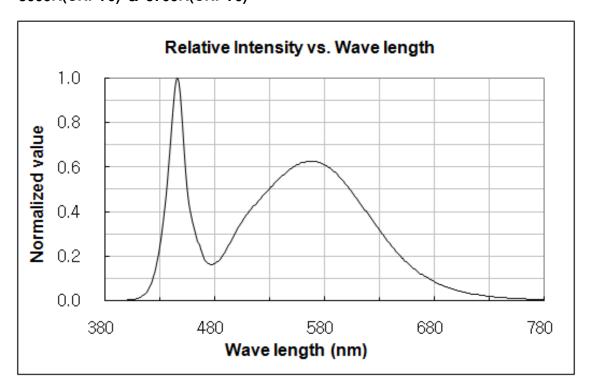
1) Spectrum Distribution

2700K(CRI 80) & 3000K(CRI 80)

 $(Tj = 85^{\circ}C)$



5000K(CRI 70) & 5700K(CRI 70)

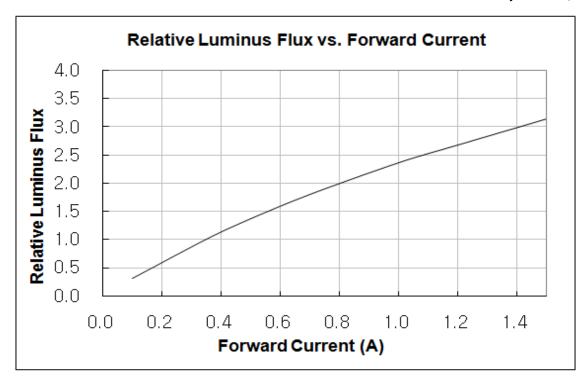




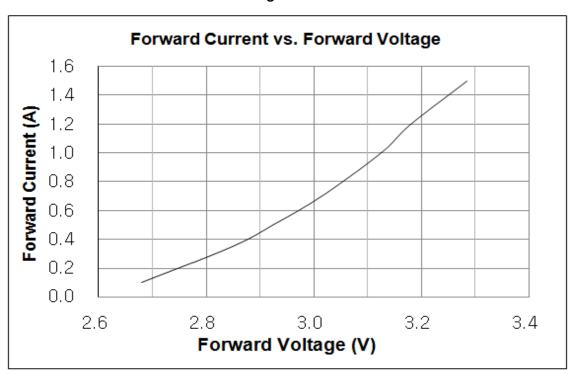
2) Forward Current Characteristics

Relative Flux vs. Forward Current

 $(Tj = 85^{\circ}C)$



Forward Current vs. Forward Voltage

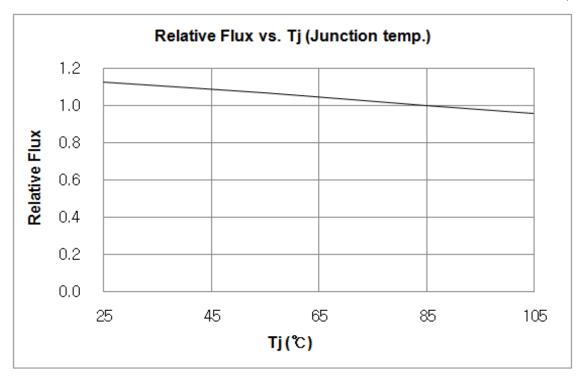




3) Temperature Characteristics

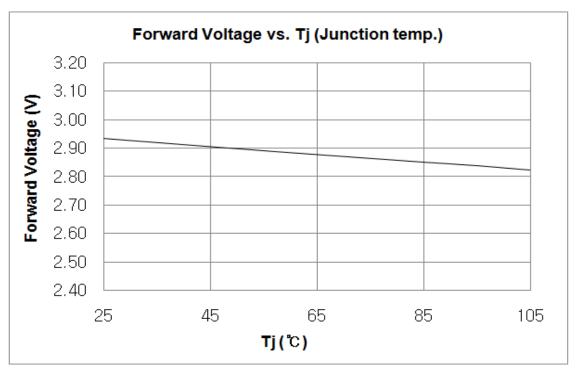
Relative Flux vs. Tj(Junction temp.)

 $(I_F = 350mA)$



Forward Voltage vs. Tj(Junction temp.)

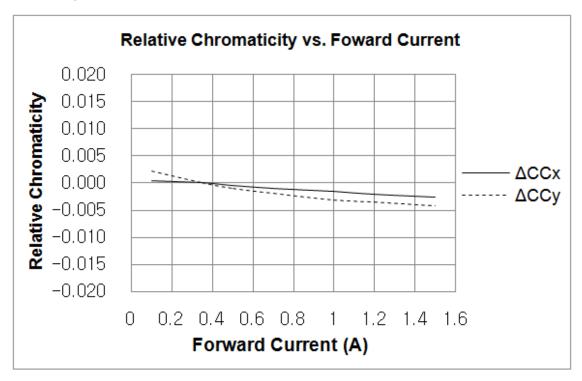
 $(I_F = 350mA)$



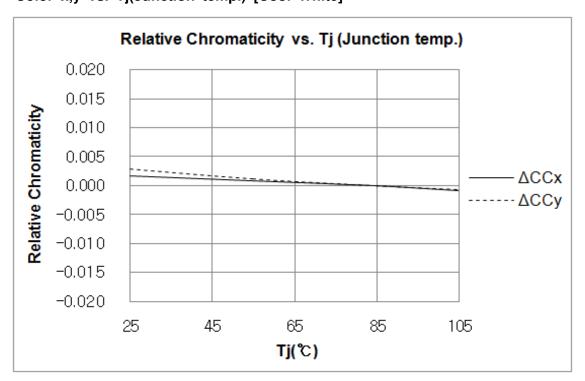


4) Color shift Characteristics

Color x,y vs. Forward Current [Cool White]

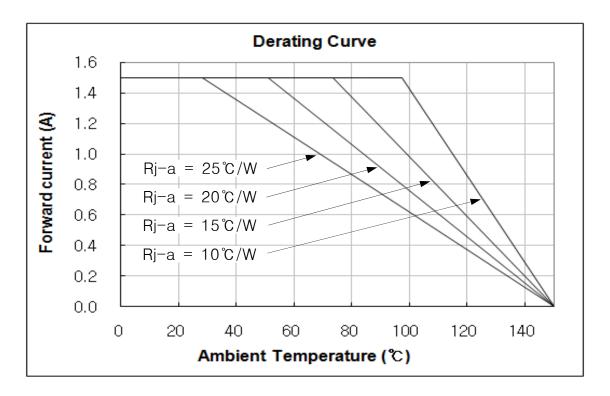


Color x,y vs. Tj(Junction temp.) [Cool White]



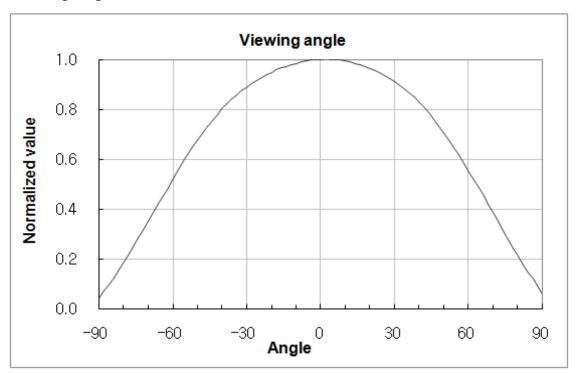


5) Derating Curve



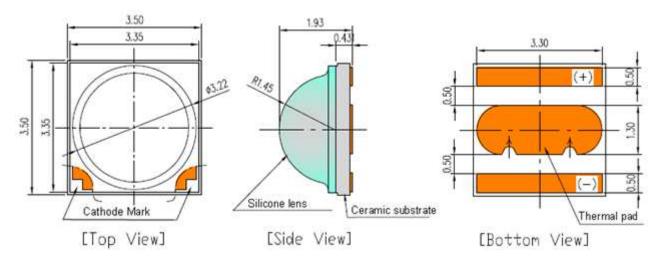
6) Viewing angle Characteristics

Viewing angle

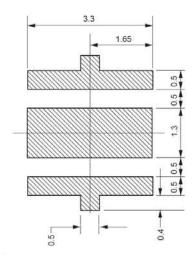




4. Outline Drawing & Dimension



Recommended Land Pattern



unit: mm

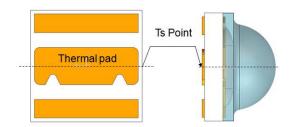
Tolerance: ± 0.13

- * This LED has built-in ESD protection device(s) connected in parallel to LED Chip(s).
- * The thermal pad is electrically isolated from the anode and cathode contact pads.

Ts Point & Measurement Method

- * Measure the nearest point to the thermal pad as shown below. If necessary, remove PSR of PCB to reach Ts point.
- * Thermal pad must be soldered to the PCB to dissipate heat properly. Otherwise, LED can be damaged.

[Bottom view]





5. Reliability Test Items and Conditions

1) Test Items and Results

Test Items	Test Conditions	Test Hours/Cycles	n
Room Temperature Life Test	25℃, DC 1000 mA	1000 Hr	22
High Temperature humidity Life Test	85℃, 85%, DC 1000 mA	1000 Hr	22
High Temperature Life Test	85℃, DC 1000 mA	1000 Hr	22
Low Temperature Life Test	-40℃, DC 1000 mA	1000 Hr	22
Temperature Humidity Cycle	-10°C ↔ 25°C 95%RH ↔ 85°C 95%RH 1000mA, 95%RH, 24hrs/1cycle	10 Cycles	11
Thermal Shock	-45 ℃/15 min ↔ 125 ℃/ 15 min. Temp.change within 5min.	500 Cycles	100
High Temperature Storage	Ta=120℃	1000 Hr	11
Low Temperature Storage	Ta=-40 ℃	1000 Hr	11
ESD(HBM)	Q1=10M Ω , R2=1.5K Ω , C=100pF, V=±5KV, 5Times	5 Times (±5kV)	5

2) Criteria for Judging the Damage

Item	Symbol	Test Condition	Lir	mit	
item	Symbol	[T _a = 25℃]	Min.	Max.	
Forward Voltage	V _F	350 mA	L.S.L. * 0.9	U.S.L. * 1.1	
Luminous flux	lm	350 mA	L.S.L. * 0.7	U.S.L. * 1.1	

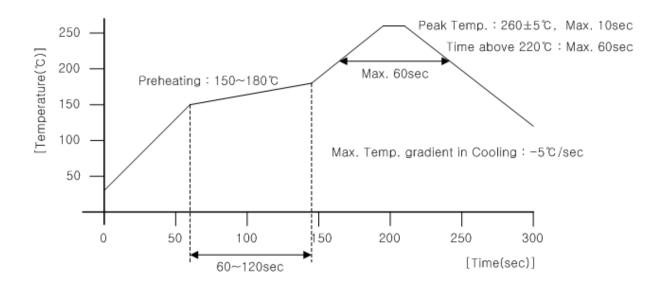
^{*} U.S.L.: Upper Standard Level L.S.L.: Lower Standard Level



6. Solder Conditions

1) Reflow Conditions (Pb Free)

Reflow Frequency: 2 times max.

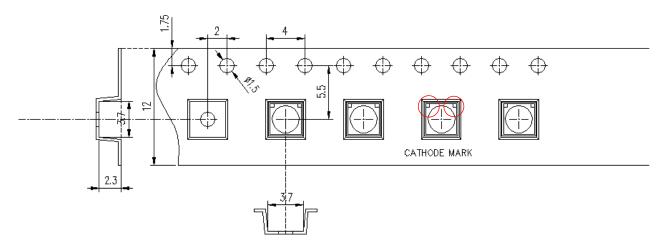


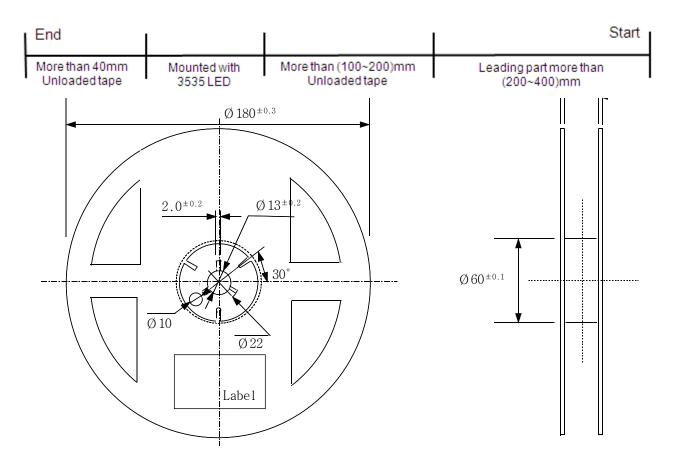
2) For Manual Soldering

Not more than 5 seconds @Max. 300℃, under soldering iron.



7. Tape And Reel



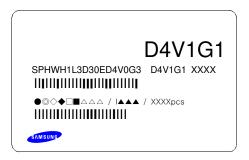


- (1) Quantity: The quantity/reel to be 1,000 pcs.
- (2) Cumulative Tolerance: Cumulative tolerance/10 pitches to be ±0.2 mm
- (3) Adhesion Strength of Cover Tape: Adhesion strength to be 0.1-0.7N when the cover tape is turned off from the carrier tape at 10° angle to be the carrier tape.
- (4) Packaging: P/N, Manufacturing data code no. and quantity to be indicated on a damp proof package.



8. Label Structure

1) Label Structure

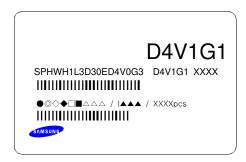


Rank Code

/D4/: VF Rank /V1/: Color Rank /G1/: Flux Bin

2) LOT Number

The Lot number is composed of the following characters



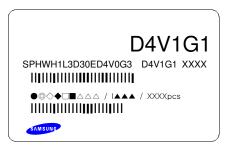
- ◎ ◇ ◆ □ △ △ △ / I ▲ ▲ ▲ / 1000 PCS
- : Production Site (S:SAMSUNG ELECTRONICS, G:Gosin China)
- : L (LED)
- ♦ : Product State (A:Normality, B:Bulk, C:First Production, R:Reproduction, S:Sample)
- ◆ : Year (S:2008, T:2009, U:2010...)
- ☐ : Month (1 ~ 9, A, B)
- : Day (1 ~ 9, A, B ~ V)
- △ : SAMSUNG ELECTRONICS Product Number (1 ~ 999)
- ▲ : Reel Number (1 ~ 999)



9. Packing Structure

1) Packing Process

Reel







Aluminum Vinyl Bag





Out Box (Max. 7 Aluminum Vinyl Bag)



Material:

Paper(DW2A/DW(AB)

TYPE	SIZE(mm)				
	a	b	\odot		
7inch	250	225	190		







2) Aluminum Packing Bag



CAUTION



This bag contains MOISTURE SENSITIVE DEVICES

- 1. Shelf life in sealed bag: 12 months at < 40°C and < 90% relative humidity (RH)
- 2. Peak package body temperature: 240 $^{\circ}\mathrm{C}$
- 3. After this bag is opened, devices that will be subjected to reflow soldor or other high temperature processes must be:
 - a. Mounted within 672 hours at factory conditions of equal to or less than 30°C /60% RH, or
 - b. Stored at < 10% RH
- 4. Devices require bake, before mounting, if: a. Humidity Indicator Card is > 65% when read at 23 ± 5 °C, or b. 2a is not met.
- Note: if device containers cannot be subjected to high temperature or shorter bake times are desired, reference IPC/JEDEC J-STD-033 for bake procedure,

Bag seal due date:

Note: Level and body temperature by IPC/JEDEC J-STD-020

(if blank, see code label)

■ 주의 사항

이 알루미늄 지퍼 백은 습기 및 정전기로부터 제품을 보호하 기 위하여 제작되었습니다. 개봉 후에는 즉시 솔더 작업을 실 시하는 것을 권장합니다.

습기 및 정전기로부터 제품을 보호 하기 위해서 개봉 후 사용 하지 않는 자재는 본 팩에 넣어 보관 하시기 바랍니다. 사용하 지 않는 자재를 본 팩에 넣을 때는 반드시 동봉된 드라이 팩 과 함께 넣고 지퍼부분을 완전하게 밀봉하여 주시기 바랍니다.

D4V1G1

SPHWH1L3D30ED4V0G3 D4V1G1 XXXX

● ◎ ◇ ◆ □ ■ △ △ △ / I ▲ ▲ ▲ / XXXXpcs











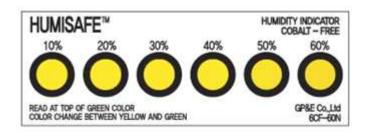


■ Important

This Al Zipper bag is designed to protect the enclosed products from moisture and ESD. Once opened, the products should be soldered onto the printed circuit board immediately. When not in use, please do not leave the products unprotected by the Al Zipper Bag. To repack unused products., please ensure the zip-lock is completely sealed with the dry pack left inside.

There are Silica Gel and Humidity Indicator Card in the Aluminum Bag







10. Precaution for use

- 1) For over current-protection, customers are recommended to apply resistors connected in series with the LEDs to mitigate sudden change of the forward current caused by shift of the forward voltage.
- 2) This device should not be used in any type of fluid such as water, oil, organic solvent, etc. When cleaning is required, IPA is recommended as cleaning agent. Solvent-based cleaning agent such as Zestron^(R) may damage the silicone resins used in the device.
- 3) When the device is in operation, the forward current should be carefully determined considering the maximum ambient temperature and the corresponding junction temperature.
- 4) LEDs must be stored in a clean environment. If the LEDs are to be stored for 3 months or more after being shipped from SAMSUNG ELECTRONICS, they should be packed with a nitrogen-filled container.
 - (Shelf life of sealed bags: 12 months, temp. 0~40°C, 0~90%RH)
- 5) After storage bag is open, device subject to soldering, solder reflow, or other high temperature processes must be:
 - a. Mounted within 672 hours (28 days) at an assembly line with a condition of no more than 30 °C/60%RH.
 - b. Stored at <10% RH.
- 6) Repack unused Products with anti-moisture packing, fold to close any opening and then store in a dry place.
- 7) Devices require baking before mounting, if humidity card reading reaches 60% at 23 ± 5 °C.
- 8) Devices must be baked for 1hours at 60 ± 5 °C, if baking is required.
- 9) The LEDs are sensitive to the static electricity and surge current. It is recommended to use a wrist band or anti-electrostatic glove when handling the LEDs. If voltage exceeding the absolute maximum rating is applied to LEDs, it may cause damage or even destruction to LED devices.
 Damaged LEDs may show some unusual characteristics such as increase in leakage current, lowered turn-on voltage, or abnormal lighting of LEDs at low current.
- 10) VOCs (volatile organic compounds) can be generated from adhesives, flux, hardener or organic additives used in luminaires (fixtures). Transparent LED silicone encapsulant is permeable to those chemicals and they may lead a discoloration of encapsualnt when they expose to heat or light. This phenomenon can cause a significant loss of light emitted(output) from the luminaires(fixtures). This phenomenon can give a significant loss of light emitted(output) from the luminaires(fixtures). In order to prevent these problems, we recommend you to know the physical properties of materials used in luminaires, They must be selected carefully.



11) Risk of Sulfurization (or Tarnishing)

The LED from Samsung Electronics uses a silver-plated lead frame and its surface color may change to black(or dark colored) when it is exposed to sulfur (S), chlorine (CI) or other halogen compound. Sulfurization of lead frame may cause intensity degradation, change of chromaticity coordinates and, in extreme cases, open circuit. It requires caution. Due to possible sulfurization of lead frame, LED should not be used and stored together with oxidizing substances made of materials in a following list, : Rubber, plain paper, lead solder cream and so on.



11. Hazard Substance Analysis



Test Report No. F650 101/LF-CTSAYAA13-31082

Issued Date: 2013.07.03 Page 1 of 5

To: SAMSUNG ELECTRONICS CO., LTD.
San 24,Nongseo-dong
Glienggn
Yongh-si
Gyeonggido
Kora

The rollowing merchandise was submitted and identified by the client as :

SGS File No. : AYAA13-31082 Product Name : SPHWH1L3D

them No./Part No. ; Ce camic 3535 Received Date ; 2013.06.28

Telit Period (2013.07.01 to 2013.07.03

To it Routifi : For firther details, please refer to 10 lowing page ≰)

To it Performed : SGS Korea tested the sample (s) selected by applicant with to lowing results.

Job Comment: : By the applicant's specific is quest, the sampling and testing was performed only for the part

hidicated in the photo without disassembly.

SGS Kores Co., Ltd.

Timothy Jeon Jinhee Kim Cindy Park

Jerry Jung/Texting Person

Jeff Jang / Chemical Lab Mgr

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F662 Vereices





Test Report No. F650 10 1/LF-CTSAYAA13-3 1082

AYAA13-31082.001

: SPHWH1L3D Sample Description ttem No./Part No. : Ce ram to 3535

Materials ; AtZID,TI,Cit,Ag,Sillcore,Pilospilor

Heavy Metals

Te at lifem a	Unit	Te at Me thad	MDL	Re culto
Candmium (Col)	mg/kg	With reference to IBC 62321/2008, ICP	0.5	W.D.
Lead (Pt)	mg/kg	With reference to IBC 623212008, ICP	5	W.D.
Mercury (Hg)	mg/kg	With reference to IBC 62321 2008, ICP	2	N.D.
Hexauateni Chromium (CrVI)	mg/kg	With reference to IBC 62321:2008, UV-VIS	1	M.D.

Rame Retardanti-PBBI/PBDEI

Te cti tem c	Unit	Te at Me thad	MDL	Re culto
Monobromoblphenyl	mg/kg	With reference to IBC 623212008, GC-MS	5	W.D.
Dibromobipheryl	mg/kg	With reference to IBC 623212008, GC-MS	5	W.D.
Tribrom objeheny!	mg/kg	With reference to IBC 623212008, GC-MS	5	W.D.
Te trabromobiphenyl	mg/kg	With reference to IBC 623212008, GC-MS	5	M.D.
Pentabromobiphenyl	mg/kg	With reference to IBC 623212008, GC-WS	5	W.D.
Hexabranoblpheryl	mg/kg	With reference to IBC 623212008, GC-MS	5	W.D.
Hep labromobilphenyl	mg/kg	With reference to IBC 623212008, GC-MS	5	M.D.
Octabromobipheryl	mg/kg	With reference to IBC 623212008, GC-MS	5	M.D.
Nonatiromobiphenyl	mg/kg	With reference to IBC 623212008, GC-MS	5	M.D.
Decabromobipheryl	mg/kg	With reference to IBC 623212008, GC-MS	5	M.D.
Monobromodiphenyl e her	mg/kg	With reference to IBC 623212008, GC-MS	5	M.D.
Dibromatiphenyl ether	mg/kg	With reference to IBC 623212008, GC-MS	5	W.D.
Tribromodiphery) e her	mg/kg	With reference to IBC 623212008, GC-MS	5	M.D.
Te trabromodiphenyl e ther	mg/kg	With reference to IBC 623212008, GC-MS	5	N.D.
Penlabromodiphenyl e her	mg/kg	With reference to IBC 623212008, GC-MS	5	W.D.
Hexabromodiphenyl e her	mg/kg	With reference to IBC 623212008, GC-MS	5	M.D.
Hep labromodiphery) e lher	mg/kg	With reference to IBC 623212008, GC-MS	5	M.D.
O clabromodiphery i e her	mg/kg	With reference to IBC 623212008, GC-MS	5	M.D.
Nonabromodiphenyl e her	mg/kg	With reference to IBC 623212008, GC-MS	5	M.D.
Decabromodiphenyl e her	mg/kg	With reference to IBC 623212008, GC-MS	5	M.D.

NOTE:

(f) N.D. - Not de fecte d.(< MDL)

② mg#g-ppm ③ MDL-Method Detection Limit

(6) -- No egitatbi

⑤ Negattue - Un de tectable / Positiue - Detectable ⑥ " - Qualitatiue analysis (No Unit)

() ' - Bolling-wate Fextraction:

Negative = Absence of Criviccating

Positive = Presence of Criviccating; the detected concentration in boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 cm 2 sample surface area.

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Issued Date: 2013, 07, 03

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F662 Vereices

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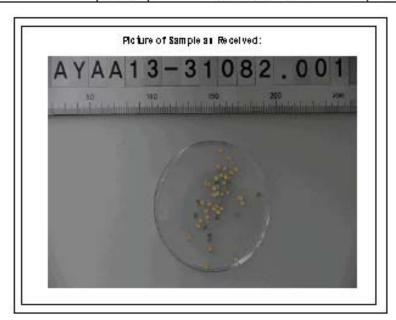
Test Report No. F690 101/LF-CTSAYAA13-51082

: AYAA13-31082.001 Sample No. : SPHWH1L3D Sample Description : Ce ram to 3535 ttem No./Part No.

Materials ; AtZI3,TI,Cii,Ag,Silcone,Phosphor

Halogen Content

Unit	Te at Me thad	MDL	Regulto
mg/kg	88 EN 14582/2007 , IC	30	M.D.
mg/kg	88 EN 14582:2007 , IC	30	M.D.
mg/kg	88 EN 14582/2007 , IC	30	W.D.
mg/kg	88 EN 14582 2007 , IC	50	W.D.
	mg/kg mg/kg mg/kg	mg/kg 88 EN 14582/2007 , IC mg/kg 88 EN 14582/2007 , IC mg/kg 88 EN 14582/2007 , IC	mg/kg 88 EN 14582/2007 , IC 30 mg/kg 88 EN 14582/2007 , IC 30 mg/kg 88 EN 14582/2007 , IC 30



NOTE:

(f) N.D. - Not de fecte d.(«MDI)

(2) mg/kg = ppm (3) MDL = Method Detection Limit

(6) -- No egitatbi

(5) Ne garttue - Un de tectable / Posittue - Detectable

6 " - Qualitatue avalysis (No Uvit)

() * - Bolling-wate Fextraction:

Negative = Absence of Crivi coating
Positive = Presence of Crivi coating; the detected concentration in boiling-water-extraction so lutton is equal or greater than 0.02 mg/kg with 50 cm 2 sample surface area.

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12), The Oralles, 3566, Pogressing, Dingsings, Snysned, Openighed, Nobel + 11-665 is 42 (6) (4) 4664-066 f + 42 (6) (4) 466-069 <u>Instrumentable color, week teen comments</u>

Issued Date: 2013.07.03 Page 3 of 5

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Test Report No. F650 101/LF-CTSAYAA13-31082

Issued Date: 2013.07.03 Page 4 of 5

Cr " Cr " Cd/Pb/Hq PBBs/PBDEs Medianic_Sample Me chanic_Sample Mechanic_Sample Mechanic_Sample Sample Measurement Sample Measurement Sample Measurement Sample Measurement Metallic Material Nonmetallic Material Solvent Estraction Acid Dige (1) on with of the Sample Microwa ve/Hotplate Spot Test / Boiling Adding Estaction Solution Mater Estraction Screen Analysis **Filtration** Adding 1,5-Heating to 90~95 C Dipinenyi carbazide tor Estraction Concentration/Dilution Residue for Color Development of Estraction Solution Hitration and p H Adjustment Total Dige ation Hitration A Red Color Indicate i the Presence of CrVI Adding 1,5-Dip iren yi carb azide for Color Development ICP-AES/AAS/MS G C/MS Confirm

UV-VII

DATA

Testing Flow Chart for RoHS:Cd/Pb/Hg/Cr# /PBBs&PBDEs Testing

The samples were dissolved totally by pie-conditioning method according to above flow chart for Cd,Pb,Hg. Section Chief : Gilbae YI

NOTE:

- (f) N.D. Not de fecte d.(≪MDL)

DATA

- ② mg/kg − ppm ③ MDL − Metiod Detection Limit
- (6) -- No egitatbi
- (5) Ne gattue Un de tectable / Positiue Detectable

DATA

- 6 " Qualitative analysis (No Unit)
- (f) 1 Boiling-wate Fextraction:

Negative - Absence of City I coarting

Positive = Presence of Crivic carting; the detected concentration in boiling-water extraction solution is equal or greater than 0.02 mg/kg w/th 50 cm 2 sample surface area.

A SECURITY OF THE PARTY OF THE SGS hores Co. Jre.

F662 Vereions

 $120, The Oralle, 2660, logical of garge, from p.d. Open gives from +11646 at (62)041 accessed to <math display="inline">\ell$ (62)041 accessed to ℓ (62)041 accessed to ℓ Hamber of the SGS (Brosp (Sodies) (far excle as Surveillance)

with UV-Mir

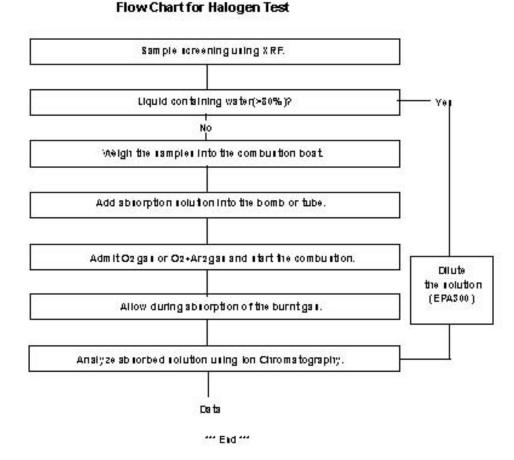
DATA





Test Report No. F690 10 1/LF-CTSAYAA13-3 1082

issued Date: 2013.07.03 Page Sorf S



NOTE: (f) N.D. - Not de tecte d.(< MDL) ② mg/kg = ppm ③ MDL = Method Detection Limit (4) -- No egitatbi (5) Ne gartiue - Un de tectable / Positiue - Detectable 6" - Qualitative analysis (No Unit) () ' = Bolling-wate Fextraction: Negative - Absence of Critico atting Positive - Presence of Crivi coating; the detected concentration in boiling-water extraction so lution is equal or greater than 0.02 mg/kg with 50 cm 2 sample surface area. THE RESERVE OF MEAN CONTROL OF MEAN MEAN OF MEAN COME COME OF MEAN OF MEAN OF MEAN AND ASSESSMENT OF MEAN OF M 12), The Divilley, 2600, Regionary, Bargungs, Snyangel, Operaging Notes = 1: 666 c = 67: 681: 1 = 666 db 6 + 47: 681 = 666 db <u>Proportion and Books, mechanis comments</u> S&S kores Co. Lie. F662 Versions Hember of the SGG Group (Sodere Generale en Surveillance)



Revision History

Date	Revision History	Writer	
		Drawn	Approved
2013.12.03	New version	I.J.PYEON	Y.T.KIM
2013.12.19	Added New Flux Rank2700K (CRI80) G3 rank4000K (CRI70) K3 rank	I.J.PYEON	Y.T.KIM